Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/716,250	DENG ET AL.	
Examiner	Art Unit	
Dao H. Nguyen	2818	

SEARCHED					
Class	Subclass	Date	Examiner		
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- John Aderson					

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

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DATE	EXMR
1/22/2006	DHN